

TEST REPORT

Product: Portfolio with 5000MAH powerbanks

Model No.: B1267

Trade mark: N/A

Report No.: TCT170220E001

Issued Date: Feb. 23, 2017

Issued for:

Guangdong, China

Issued By:

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	9.		SS253 DOD
	10.		



1. Test Certification

Product:	Portfolio with	Portfolio with 5000MAH powerbanks					
Model No.:	B1267	(3)	(4)	(60)			
Applicant:							
Address:		Guangdor	ng, China	(Co)			
Manufacturer:							
Address:		Guangdor	ng, China				
Test Voltage:			/ ±10 V, 50/ 60 Hz), / ±10 V, 50/ 60 Hz),				
Date of Test:	Feb. 20, 2017	7 ~ Feb. 22, 2017					
Applicable Standards:	EN 61000-3-2 EN 61000-3-3		(6)	(3)			

The above equipment has been tested by Shenzhen TCT Testing Technology Co., Ltd. and found compliance with the requirements set forth in the technical standards mentioned above. The results of testing in this report apply only to the product/system, which was tested. Other similar equipment will not necessarily produce the same results due to production tolerance and measurement uncertainties.

Tested By:

Jerry

Check By:

Date: Feb. 22, 2017

Date: Feb. 23, 2017

Date: Feb. 23, 2017

Date: Feb. 23, 2017



2. Test Result Summary

Emission							
Test Method	Item	Result					
	Conducted Emission at AC Mains Power Ports	Pass					
EN 55032: 2012+AC: 2013	Conducted Emission at Analogue/Digital Data Ports	N/A					
	Radiated Emission	Pass					
EN 61000-3-2: 2014	Harmonic Current Emissions	N/A					
EN 61000-3-3: 2013	Voltage Fluctuations & Flicker	Pass					

Immunity (EN 55024: 2010+A1: 2015)							
Test Method	Item	Result					
EN 61000-4-2: 2009	Electrostatic Discharge (ESD)	Pass					
EN 61000-4-3: 2006 +A1: 2008+A2: 2010	Radio-frequency Electromagnetic Field Amplitude Modulated (RS)	Pass					
EN 61000-4-4: 2012	Electrical Fast Transients (EFT)	Pass					
EN 61000-4-5: 2014	Surges	Pass					
EN 61000-4-6: 2014	Radio-frequency Continuous Conducted (CS)	Pass					
EN 61000-4-8: 2010	Power-frequency Magnetic Fields (PFMF)	N/A					
EN 61000-4-11: 2004	Voltage Dips & Voltage Interruptions	Pass					

Note:

- 1. Pass: Test item meets the requirement.
- 2. Fail: Test item does not meet the requirement.
- 3. N/A: Test case does not apply to the test object.
- 4. The test result judgment is decided by the limit of test standard.
- 5. The information of measurement uncertainty is available upon the customer's request.

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3. EUT Description

	me:	Portfolio with 5000MAH powerbanks						
del No.:		B1267	B1267					
oduct Pa	rameter:	Input: DC Output: DC	Input: DC 5 V, 2 A Output: DC 5 V 2 1 A					
Mains:		Shielde	d Unshi	elded, 🔲	Detachable	☐Un-det	achable	
B Line:		Shielde	d 🛛 Unshi	elded, 🛛		☐Un-det	achable	
ntrol Lin	e:	Shielde	d Unshi	elded, 🔲		☐Un-det	achable	
		⊠ivot app	olicable	Length:			_	
3								
			3		(6)		Ø	
3						0		
			(C)				(4)	
3								
	Mains: B Line: ntrol Lin	B Line: Introl Line:	Mains: Shielde Not app Shielde Not app Shielde Not app Shielde Not app Shielde Not ap	Mains: Shielded Unshielded Shielded Unshielded Unshielded	Mains: Shielded	Mains: Shielded Unshielded, Detachable Not applicable Length: Not applicable Length:	Mains: Shielded Unshielded, Detachable Un-det Not applicable Length:	



4. Test Methodology

4.1. Decision of Final Test Mode

The EUT was tested together with the thereinafter additional components, and a configuration, which produced the worst emission levels, was selected and recorded in this report.

The following test mode(s) were assessed:

Test Mode

Mode 1: Charging

Mode 2: Discharging

4.2. EUT System Operation

- Set up EUT with the support equipments.
- 2. Make sure the EUT work normally during the test.



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5. Setup of Equipment under Test

5.1. Description of Support Units

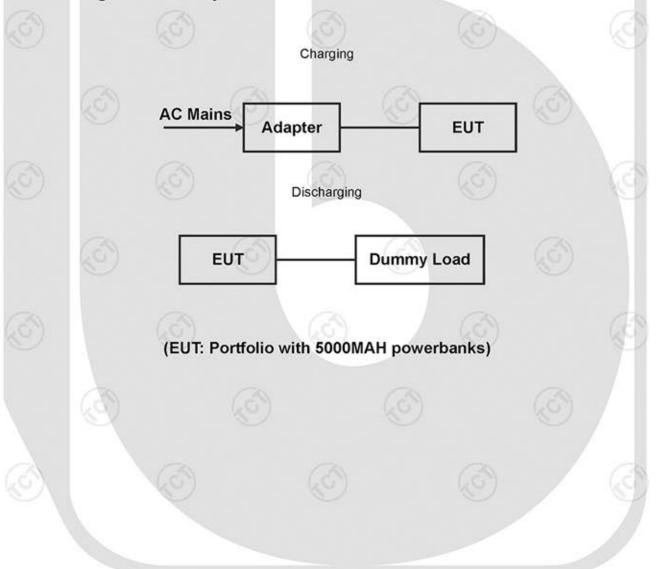
The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

Equipment	Model No.	Serial No.	FCC ID	Trade Name
Adapter	JD-050200	20120109075 76735	1	JD

Note:

- All the equipment/cables were placed in the worst-case configuration to maximize the emission during the test.
- Grounding was established in accordance with the manufacturer's requirements and conditions for the intended use.

5.2. Configuration of System Under Test



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6. Facilities and Accreditations

6.1. Facilities

All measurement facilities used to collect the measurement data are located at TCT Lab.

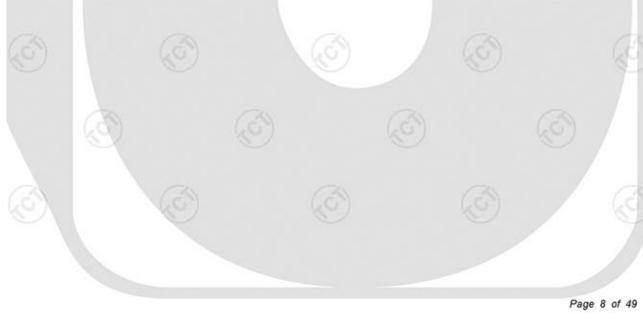
The sites are constructed in conformance with the requirements of ANSI C63.4 and CISPR Publication 22. All receiving equipment conforms to CISPR Publication 16-1, "Radio Interference Measuring Apparatus and Measurement Methods."

6.2. Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

No.	Item	MU
1.	Temperature	±0.1℃
2.	Humidity	±1.0 %
3.	Spurious Emissions, Conducted	±2.56 dB
4.	All Emissions, Radiated	±4.50 dB

This uncertainty represents an expanded uncertainty expressed at approximately the 95 % confidence level using a coverage factor of k=2.





7. Emission Test

7.1. Conducted Emission at AC Mains Power Ports

7.1.1. Test Specification

Test Requirement:	EN 55032	
Test Method:	EN 55032	(6)
Frequency Range:	150 kHz to 30 MHz	

7.1.2. Limits

Fraguency (MHz)	Class A	dB(uV)	Class B dB(uV)	
Frequency (MHz)	Quasi-peak	Average	Quasi-peak	Average
0.15 - 0.5	79	66	66 - 56	56 - 46
0.50 - 5.0	73	60	56	46
5.0 - 30.0	73	60	60	50

7.1.3. Test Instruments

Conducted Emission Shielding Room Test Site (843)						
Equipment	Manufacturer	Model	Serial Number	Calibration Due		
EMI Test Receiver	R&S	ESCS30	100139	Aug. 11, 2017		
LISN	Schwarzbeck	NSLK 8126	8126453	Aug. 16, 2017		

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

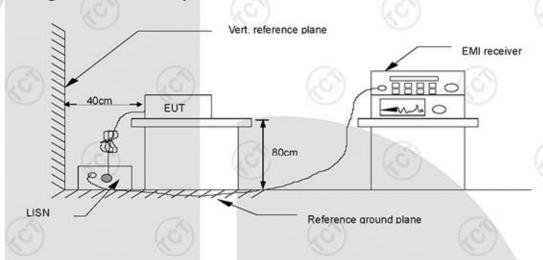
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7.1.4. Test Method

The AMN was placed 0.8 m from the boundary of the unit under test and bonded to a ground reference plane. This distance was between the closest points of the AMN and the EUT. All other units of the EUT and associated equipment was at least 0.8 m from the AMN. All power was connected to the system through Artificial Mains Network (AMN). Conducted voltage measurements on mains lines were made at the output of the AMN.

7.1.5. Block Diagram of Test Setup



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.1.6. Test Results

Test Environment:	Temp.:	23 ℃	Humid.:	54 %	Press.:	96 kPa
Test Mode:	Mode 1	1	66	\$	660	
Test Voltage:			Input AC 230 Input AC 110			
Remark:	The high	hest emis	ssion level wa est report.			/ 50 Hz and
Test Result:	Pass				7	

Note:

L1 = Live Line / N = Neutral Line

"---" denotes the emission level was or more than 2 dB below the Average limit, so no re-check anymore.

Freq. = Emission frequency in MHz

Reading level $dB(\mu V)$ = Receiver reading

Corr. Factor (dB) = Attenuator factor + Cable loss

Level $dB(\mu V)$ = Reading level $dB(\mu V)$ + Corr. Factor (dB)

Limit $dB(\mu V)$ = Limit stated in standard

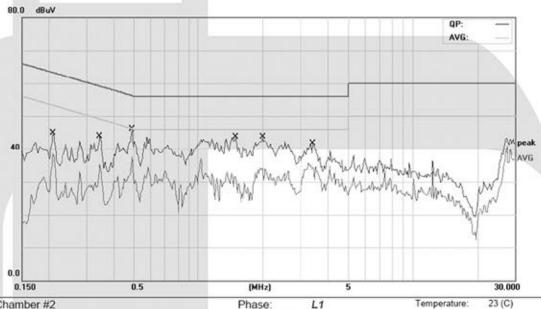
Margin (dB) = Level dB(μ V) – Limits dB(μ V)

Q.P. =Quasi-Peak

AVG=Average



Please refer to following diagram for individual



Site Chamber #2

Limit: EN55032 Class B Conduction(QP)

Mode: Charging

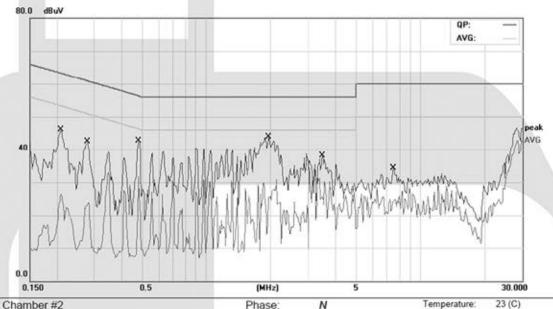
Note: DC 5V(Adapter Input AC 230V/50Hz)

Phase: L1		Temperature:	2	
Power:		Humidity: 54	%	

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over		
		MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment
1		0.2086	30.67	11.47	42.14	63.26	-21.12	QP	
2		0.2086	27.57	11.47	39.04	53.26	-14.22	AVG	
3		0.3453	26.37	11.40	37.77	59.07	-21.30	QP	
4		0.3453	21.74	11.40	33.14	49.07	-15.93	AVG	
5		0.4898	30.88	11.31	42.19	56.17	-13.98	QP	
6	•	0.4898	24.50	11.31	35.81	46.17	-10.36	AVG	
7		1.4898	25.38	11.45	36.83	56.00	-19.17	QP	
8		1.4898	17.91	11.45	29.36	46.00	-16.64	AVG	
9		1.9977	25.98	11.70	37.68	56.00	-18.32	QP	
10		1.9977	18.47	11.70	30.17	46.00	-15.83	AVG	
11		3.4336	28.01	11.18	39.19	56.00	-16.81	QP	
12		3.4336	19.88	11.18	31.06	46.00	-14.94	AVG	A la







Site Chamber #2

Limit: EN55032 Class B Conduction(QP)

Mode: Charging

Note: DC 5V(Adapter Input AC 230V/50Hz)

Phase:	- 1
Power:	

Temperature:

Humidity:

No. Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
	MHz	dBuV	dB	dBuV	dBuV	dB	Detector	Comment	
1	0.2086	29.61	11.47	41.08	63.26	-22.18	QP		
2	0.2086	17.46	11.47	28.93	53.26	-24.33	AVG		
3	0.2789	25.90	11.43	37.33	60.85	-23.52	QP		
4	0.2789	13.19	11.43	24.62	50.85	-26.23	AVG		1
5 *	0.4820	31.05	11.32	42.37	56.30	-13.93	QP		in the same of the
6	0.4820	20.15	11.32	31.47	46.30	-14.83	AVG		
7	1.9625	23.53	11.68	35.21	56.00	-20.79	QP		
8	1.9625	13.11	11.68	24.79	46.00	-21.21	AVG		
9	3.5000	17.72	11.16	28.88	56.00	-27.12	QP		
10	3.5000	10.58	11.16	21.74	46.00	-24.26	AVG		
11	7.4883	15.01	11.01	26.02	60.00	-33.98	QP		
12	7.4883	6.02	11.01	17.03	50.00	-32.97	AVG		





7.2. Conducted Emission at Analogue/Digital Data Ports

7.2.1. Test Specification

Test Requirement:	EN 55032	(6)
Test Method:	EN 55032	
Frequency Range:	150 kHz to 30 MHz	60

7.2.2. Limits

Posto Tunos	Optical Fibre Ports with metallic shield or tension members						
Ports Types	Wired Netw	ork Ports					
Cables Types	Balanced Unscreened, Screened or Coaxial						
Frequency (MHz)	Voltage Class A		Current limits Class A dB(uA)				
rroquency (mriz)	Quasi-peak	Average	Quasi-peak	Average			
0.15 - 0.5	97 - 87	84 - 74	53 - 43	40 - 30			
0.5 - 30.0	87	74	43	30			

Bouto Tunos	Optical Fibre Ports with metallic shield or tension members							
Ports Types	Wired Netw	ork Ports						
Cables Types	Balanced Unscreened, Screened or Coaxial							
Frequency (MHz)	Voltage Class B		Current limits Class B dB(uA)					
,	Quasi-peak	Average	Quasi-peak	Average				
0.15 - 0.5	84 - 74	74 - 64	40 - 30	30 - 20				
0.5 - 30.0	74	64	30	20				

Note:

1. Applicable to ports listed above and intended to connect to cables longer than 3 m.

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7.2.3. Test Instruments

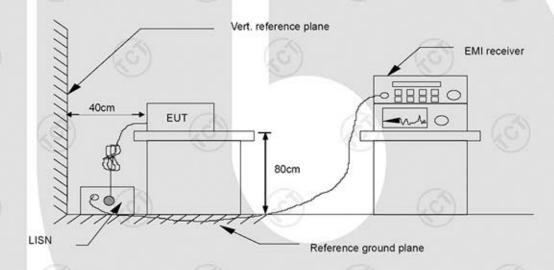
Conducted Emission Shielding Room Test Site (843)									
Equipment	Manufacturer	Model	Serial Number	Calibration Due					
Test Receiver	R&S	ESCS30	100139	Aug. 11, 2017					
ISN	R&S	ENY81	100054	Aug. 11, 2017					
ISN	R&S	ENY81-CA6	101564	Aug. 11, 2017					
Current probe	Schwarzbeck	F-33-2	427	Aug. 11, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

7.2.4. Test Method

All power was connected to the system through Artificial Mains Network (AMN). All tested telecommunications lines were connected to an Impedance Stabilization Network (ISN) and conducted voltage measurements on telecommunications lines were made at the output of the ISN. Where an ISN was not appropriate or available measurements were made using a Capacitive Voltage Probe and Current probe.

7.2.5. Block Diagram of Test Setup



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.2.6. Test Results

Note: This test isn't applicable because the EUT doesn't have relative function.



7.3. Radiated Emission

7.3.1. Test Specification

Test Requirement:	EN 55032
Test Method:	EN 55032
Frequency Range:	30 MHz to 1000 MHz
Measurement Distance:	3 m
Antenna Polarization:	Horizontal & Vertical

7.3.2. Limits

Below 1 GHz

Eroguanov (MHz)	dB(uV/m) (At 3m)	dB(uV/m) (At 3m)
Frequency (MHz)	Class A	Class B
30 - 230	50	40
230 - 1000	57	47

Note: 1. The lower limit shall apply at the transition frequency.

2. Additional provisions may be required for cases where interference occurs.

Above 1 GHz

	Clas	ss A	Class B		
Frequency (GHz)	Average dB(uV/m)	Peak dB(uV/m)	Average dB(uV/m)	Peak dB(uV/m)	
1 - 3	56	76	50	70	
3-6	60	80	54	74	

7.3.3. Test Instruments

Radiated Emission Test Site (966)									
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
EMI Test Receiver	R&S	ESVD	100008	Aug. 11, 2017					
Spectrum Analyzer	R&S	FSEM	848597-001	Aug. 11, 2017					
Amplifier	HP	8447D	2727A05017	Aug. 11, 2017					
Amplifier	EM	EM30265	07032613	Aug. 11, 2017					
Broadband Antenna	Schwarzbeck	VULB9163	340	Aug. 13, 2017					
Horn Antenna	Schwarzbeck	BBHA 9120D	631	Aug. 13, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

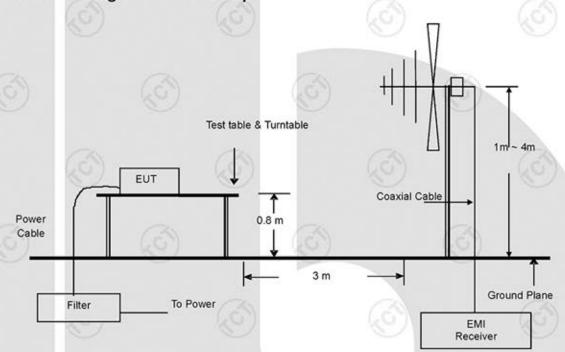


TCT通测检测

7.3.4. Test Method

Measurements were made in a 3-meter semi-anechoic chamber or Open Area Test Site that complies to CISPR 16. Preliminary (peak) measurements were performed at an antenna to EUT separation distance of 3 meter. The EUT was rotated 360° about its azimuth with the receive antenna located at various heights in horizontal and vertical polarities. Final measurements (quasi-peak) were then performed by rotating the EUT 360° and adjusting the receive antenna height from 1 to 4 m. All frequencies were investigated in both horizontal and vertical antenna polarity, where applicable. Block Diagram of Test Setup.

7.3.5. Block Diagram of Test Setup



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.



7.3.6. Test Results

Test Environment:	Temp.:	25 ℃	Humid.:	54 %	Press.:	96 kPa	
Test Mode:	Mode 1	6	(%)	(ď		(3)	
Test Voltage:	DC 5 V (Adapter Input AC 230 V ±10 V, 50/ 60 Hz), DC 5 V (Adapter Input AC 110 V ±10 V, 50/ 60 Hz), DC 5 V						
Remark:	The hig	hest emis	ssion level wa		the same of the sa	The same of the sa	
Test Result:	Pass						

Note:

Freq. = Emission frequency in MHz

Reading level dB(µV) = Receiver reading

Corr. Factor (dB) = Antenna factor + Cable loss

Measurement $dB(\mu V/m) = Reading level dB(\mu V) + Corr. Factor (dB)$

Limit dB(µV/m) = Limit stated in standard

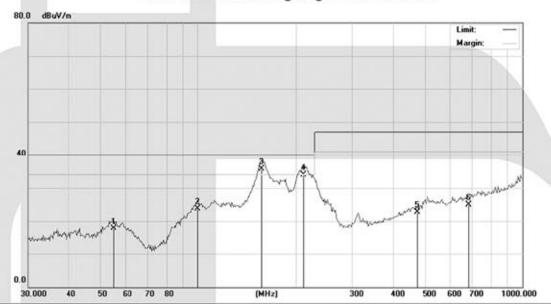
Margin (dB) = Measurement dB(μ V/m) – Limits dB(μ V/m)

Q.P. =Quasi-Peak





Please refer to following diagram for individual



Site

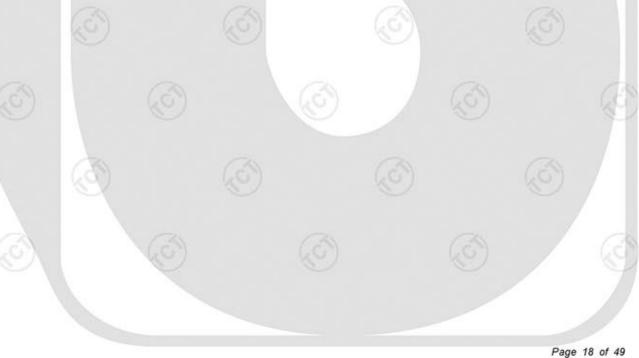
Limit: EN 55032 Class B RE_3 M

Mode: Charging

Note: DC 5V(Adapter Input AC 230V/50Hz)

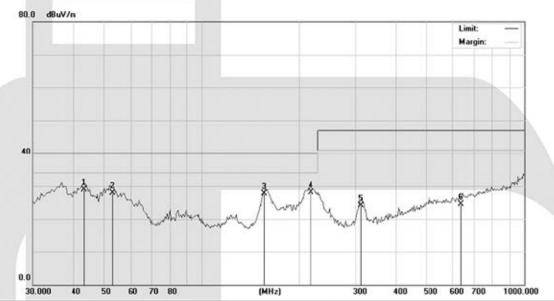
Polarization: Horizontal Temperature: 25 Humidity: 54 % Power:

No.	Mk	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over			
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment	
-1		55.0423	30.20	-12.42	17.78	40.00	-22.22	QP		
2		99.8598	35.20	-11.45	23.75	40.00	-16.25	QP		
3		157.4244	50.29	-14.63	35.66	40.00	-4.34	QP		
4		210.8524	45.20	-11.30	33.90	40.00	-6.10	QP		
5		473.6004	26.50	-3.81	22.69	47.00	-24.31	QP		
6		678.5858	25.30	-0.31	24.99	47.00	-22.01	QP		



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Site

Limit: EN 55032 Class B RE 3 M

Mode: Charging

Note: DC 5V(Adapter Input AC 230V/50Hz)

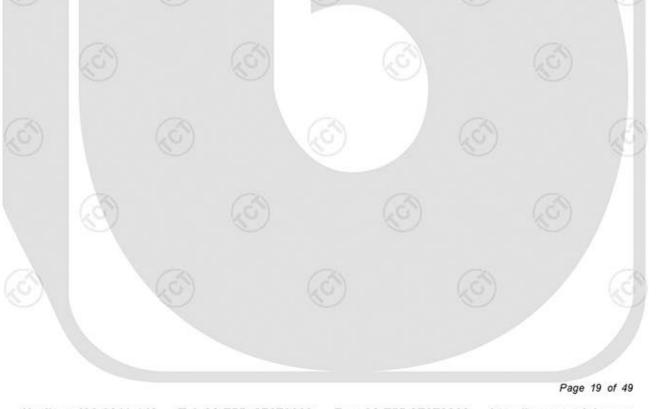
Polarization: Vertical

Temperature: 25

Power:

Humidity: 54 %

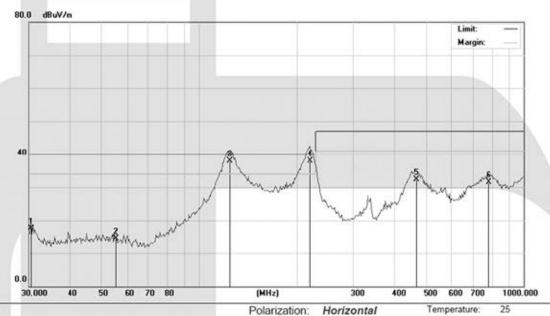
No.	Mk	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over				
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment	N	
1	*	43.2270	41.20	-12.33	28.87	40.00	-11.13	QP			
2		52.9191	40.23	-12.25	27.98	40.00	-12.02	QP			
3		156.5422	42.30	-14.69	27.61	40.00	-12.39	QP			
4	1	218.0830	39.20	-11.05	28.15	40.00	-11.85	QP			
5		310.7233	32.15	-8.02	24.13	47.00	-22.87	QP			
6		637.9096	25.60	-1.15	24.45	47.00	-22.55	QP			





Humidity:

54 %



Site

Limit: EN 55032 Class B RE_3 M

Mode: Discharging

Note:

No.	Mk	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over				
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment		
1		30.5100	31.20	-13.65	17.55	40.00	-22.45	QP			
2		55.3525	26.80	-12.45	14.35	40.00	-25.65	QP			
3		124.3284	52.10	-14.25	37.85	40.00	-2.15	QP			N.
4	1	220.5477	48.80	-10.96	37.84	40.00	-2.16	QP			
5		468.3074	36.20	-3.99	32.21	47.00	-14.79	QP			
6		780.9397	30.20	1.21	31.41	47.00	-15.59	QP			

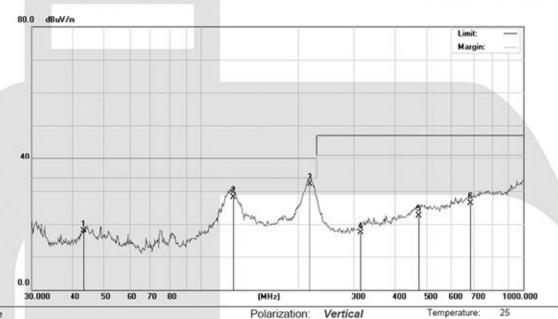
Power:

DC 5V



Humidity:

54 %



Site

Limit: EN 55032 Class B RE_3 M

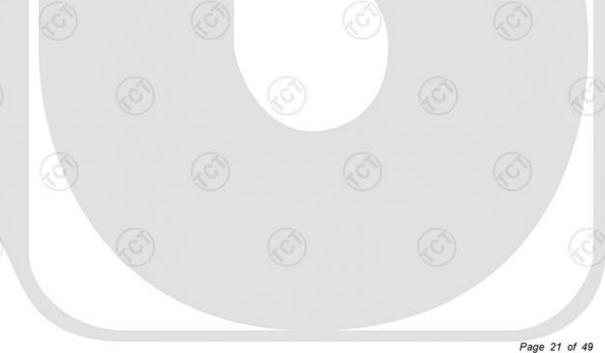
Mode: Discharging

Note:

No.	Mk.	Freq.	Reading Level	Correct Factor	Measure- ment	Limit	Over				
		MHz	dBuV	dB	dBuV/m	dBuV/m	dB	Detector	Comment		
1		43.4705	30.20	-12.33	17.87	40.00	-22.13	QP		9	
2		126.4422	42.60	-14.54	28.06	40.00	-11.94	QP			
3	*	218.0830	43.20	-11.05	32.15	40.00	-7.85	QP			
4		312.4743	25.30	-7.99	17.31	47.00	-29.69	QP			
5		473.6003	26.40	-3.81	22.59	47.00	-24.41	QP			
6		686.2554	26.50	-0.15	26.35	47.00	-20.65	QP			

Power:

DC 5V





7.4. Harmonic Current Emissions

7.4.1. Test Specification

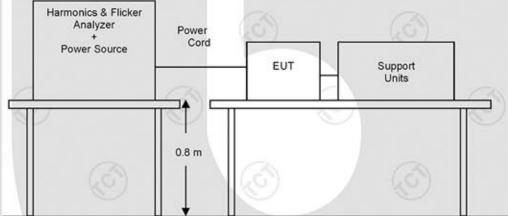
Test Requirement:	EN 61000-3-2
Test Method:	EN 61000-3-2
Limits:	Class A

7.4.2. Test Instruments

,	Harmonic Test Equipment								
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
AC Power Supply	KIKUSUI	PCR4000M	UC002552	Aug. 11, 2017					
Harmonic/Flicker Analyzer	KIKUSUI	KHA1000	UD002324	Aug. 11, 2017					
Multi Outlet Unit	KIKUSUI	OT01-KHA	UF003026	Aug. 11, 2017					
Line Impedance Network	KIKUSUI	LIN1020JF	UC001738	Aug. 11, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

7.4.3. Block Diagram of Test Setup



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.4.4. Test Results

Note: This test isn't applicable because the EUT doesn't have relative function.

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7.5. Flicker and Voltage Fluctuation

7.5.1. Test Specification

Test Requirement:	EN 61000-3-3
Test Method:	EN 61000-3-3

7.5.2. Limits

Test Item	Limit	Note				
Pst	1.0	Pst means short-term flicker indicator				
Plt	0.65	Plt means long-term flicker indicator				
Tdt (ms)	500	Tdt means maximum time that dt exceeds 3 %.				
dmax (%)	4/6/7	Dmax means maximum relative voltage change.				
dc (%)	3.3	Dc means relative steady-state voltage change.				

7.5.3. Test Instruments

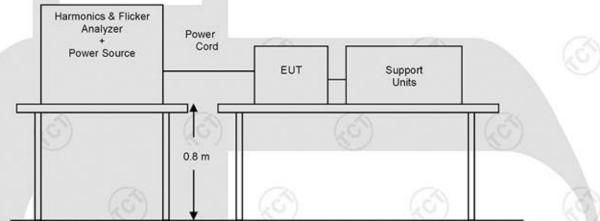
Flicker Test Equipment									
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
AC Power Supply	KIKUSUI	PCR4000M	UC002552	Aug. 11, 2017					
Harmonic/Flicker Analyzer	KIKUSUI	KHA1000	UD002324	Aug. 11, 2017					
Multi Outlet Unit	KIKUSUI	OT01-KHA	UF003026	Aug. 11, 2017					
Line Impedance Network	KIKUSUI	LIN1020JF	UC001738	Aug. 11, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

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7.5.4. Block Diagram of Test Setup



For the actual test configuration, please refer to the related item - Photographs of the Test Configuration.

7.5.5. Test Results

Test Environment:	Temp.: 23 ℃	Humid.: 51 %	Press.:	96 kPa
Test Mode:	Mode 1			
Test Voltage:	DC 5 V(Adapter In	put AC 230 V/ 50 Hz)		(4
Test Result:	Pass			

Test Data of Voltage Fluctuation and Flicker

Final Test Result Pass
Nominal Voltage 230 V
Nominal Frequency 50 Hz
Plt Test Duration 600 s
Flicker Margin 100 %
d Measurement Margin 100 %

Segment	Pst	dmax(%)	dc(%)	d(t)>3.3%(ms)	Judge
Limit	1.000	4.000	3.300	500	
Seg. 1	0.009	0.074	0.004	0	Pass

Pit	Value	Judge
Limit	0.650	
Measurement	0.004	Pass



8. Immunity Test

8.1. General Performance Criteria Description

	Criterion A:	During and after the test the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed below a minimum performance level specified by the manufacturer when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. If the minimum performance level or the permissible performance loss is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.
)	Criterion B:	After the test, the EUT shall continue to operate as intended without operator intervention. No degradation of performance or loss of function is allowed, after the application of the phenomena below a performance level specified by the manufacturer, when the EUT is used as intended. The performance level may be replaced by a permissible loss of performance. During the test, degradation of performance is allowed. However, no change of operating state or stored data is allowed to persist after the test.
)		If the minimum performance level (or the permissible performance loss) is not specified by the manufacturer, then either of these may be derived from the product description and documentation, and by what the user may reasonably expect from the EUT if used as intended.
	Criterion C:	Temporary loss of function is allowed, provided the functions is self-recoverable or can be restored by the operation of controls by the user in accordance with the manufacturer instructions.
		Functions, and/or information stored in non-volatile memory, or protected by a battery backup, shall not be lost.

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8.2. Electrostatic Discharge (ESD)

8.2.1. Test Specification

Test Requirement:	EN 55024	
Test Method:	EN 61000-4-2	
Storage capacitor:	150 pF	
Discharge resistor:	330 ohm	
Discharge Voltage:	Contact Discharge: ±4 kV Air Discharge: ±8 kV Indirect application: ±4 kV	
Polarity:	Positive & Negative	
Number of Discharge:	Least 100 each at negative and positive polarity	1
Discharge Mode:	1 time/s	
Performance Criterion:	B (c)	

8.2.2. Test Instruments

	Immunity Shielded Room								
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
Electrostatic Discharge Generator	Prima	ESD61002AG	PR12092502	Aug. 11, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

8.2.3. Test Method

1. Air Discharge:

The test was applied on non-conductive surfaces of EUT. The round discharge tip of the discharge electrode was approached as fast as possible to touch the EUT. After each discharge, the discharge electrode was removed from the EUT. The generator was re-triggered for a new single discharge and repeated 20 times for each pre-selected test point. This Method was repeated until all the air discharge completed.

2. Contact Discharge:

The test was applied on accessible metallic parts of the EUT. The generator was re-triggered for a new single discharge and repeated 50 times for each pre-selected test point. The tip of the discharge electrode was touching the EUT before the discharge switch was operated.

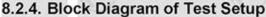


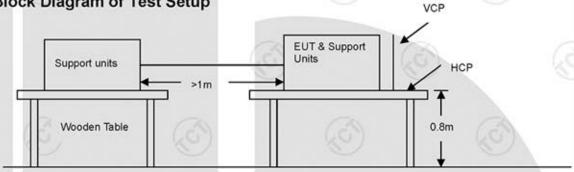
3. Indirect discharge for horizontal coupling plane:

At least 10 single discharges (in the most sensitive polarity) were applied to the horizontal coupling plane, at points on each side of the EUT. The discharge electrode positions vertically at a distance of 0.1 m from the EUT and with the discharge electrode touching the coupling plane.

4. Indirect discharge for vertical coupling plane:

At least 10 single discharges (in the most sensitive polarity) were applied to the center of one vertical edge of the coupling plane. The coupling plane, of dimensions 0.5 m X 0.5 m, was placed parallel to, and positioned at a distance of 0.1 m from the EUT. Discharges were applied to the coupling plane, with this plane in sufficient different positions that the four faces of the EUT are completely illuminated.





Note:

Ground Reference Plane

1. Table-top Equipment

The configuration consisted of a wooden table 0.8 meters high standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system. A Horizontal Coupling Plane (1.6 m x 0.8 m) was placed on the table and attached to the GRP by means of a cable with 940 k total impedance. The equipment under test was installed in a representative system as described in section 7 of EN 61000-4-2, and its cables were placed on the HCP and isolated by an insulating support of 0.5 mm thickness. A distance of 1-meter minimum was provided between the EUT and the walls of the laboratory and any other metallic structure.

2. Floor-standing Equipment

The equipment under test was installed in a representative system as described in section 7 of IEC 61000-4-2, and its cables were isolated from the Ground Reference Plane by an insulating support of 0.1-meter thickness. The GRP consisted of a sheet of aluminum that is at least 0.25 mm thick, and 2.5 meters square connected to the protective grounding system and extended at least 0.5 meters from the EUT on all sides.



8.2.5. Test Results

Test Environment:	Temp.:	23 ℃	Humid.:	54 %	Press.:	96 kPa	
Test Mode: Mode 1, Mode 2							
Test Voltage:	DC 5 V(Adapter Input AC 230 V/ 50 Hz), DC 5 V						
Test Result:	Pass	<i>i</i> .	(3)		(A)		

		Air Di	scharg	je		
1	Test Levels	t Levels Results				
Test Points	± 8 kV	Pass	Fail	Performance Criterion	Observation	
USB Port 4 Points		\boxtimes		В	Note	
Slot 4 Points		\boxtimes		В	Note ☐1 ☐2 ☐3	

Contact Discharge							
	Test Levels			Results			
Test Points	± 4 kV	Pass Fail Performance Criterion		Observation			
HCP 4 Points	\boxtimes	\boxtimes		В	Note		
VCP 4 Points		\boxtimes		В	Note		

Note:

- There was no change compared with initial operation during and after the test. No unintentional response was found during the test.
- 2. The function stopped during the test, but can be recoverable by itself operation after the test.
- 3. The function stopped during the test, but can be recoverable manually after the test.

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8.3. Radio-frequency Electromagnetic Field Amplitude Modulated (RS)

8.3.1. Test Specification

Test Requirement:	EN 55024	((0)
Test Method	EN 61000-4-3	
Frequency Range:	80 MHz -1000 MHz	
Test level:	3 V/m (unmodulated, r.m.s)	
Modulation:	1 kHz, 80 % AM, sine wave	
Frequency Step:	1 % of preceding frequency value	
Polarity of Antenna:	Horizontal & Vertical	
Antenna Height:	1.5 m	67
Performance Criterion	ı: A	

8.3.2. Test Instruments

743 RS Chamber									
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
Signal Generator	Maconi	2022D	119246/003	Aug. 11, 2017					
Power Amplifier	M2S	A00181-1000	9801-112	Aug. 11, 2017					
Power Amplifier	M2S	AC8113/ 800-250A	9801-179	Aug. 11, 2017					
Power Antenna	SCHAFFNER	CBL6140A	1204	Aug. 11, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

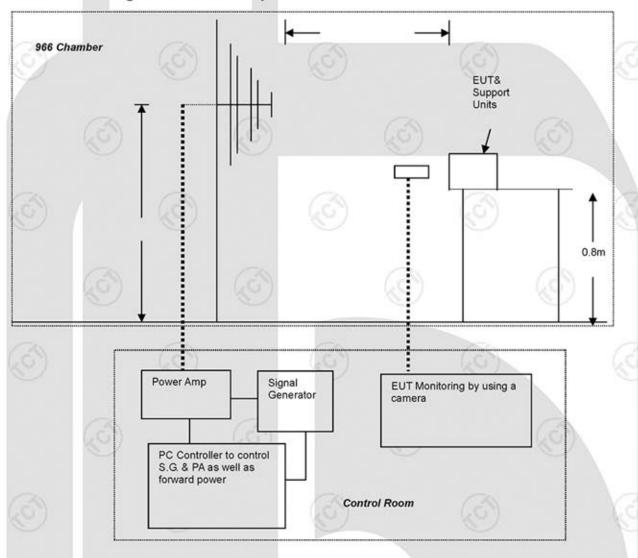
8.3.3. Test Method

- 1. The testing was performed in a fully anechoic chamber. The transmit antenna was located at a distance of 3 meters from the EUT.
- 2. The frequency range is swept from 80 MHz to 1000 MHz, with the signal 80% amplitude modulated with a 1 kHz sine-wave. The rate of sweep did not exceed 1.5 x 10⁻³ decade/s, where the frequency range is swept incrementally; the step size was 1% of preceding frequency value.
- 3. The dwell time at each frequency shall be not less than the time necessary for the EUT to be able to respond and was not less than 0.5 s.
- The test was performed with the EUT exposed to both vertically and horizontally polarized fields on each of the four sides.
- The EUT was performed in a configuration to actual installation conditions, a video camera and/or a audio monitor were used to monitor the performance of the EUT.

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8.3.4. Block Diagram of Test Setup



Note:

1. Table-top Equipment

The EUT installed in a representative system as described in section 7 of EN 61000-4-3 was placed on a non-conductive table 0.8 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.

2. Floor-standing Equipment

The EUT installed in a representative system as described in section 7 of IEC 61000-4-3 was placed on a non-conductive wood support 0.1 meters in height. The system under test was connected to the power and signal wire according to relevant installation instructions.



8.3.5. Test Results

Test Environment:	Temp.:	24 ℃	Humid.:	55 %	Press.:	96 kPa
Test Mode:	Mode 1,	Mode 2	9	(6		(0)
Test Voltage: DC 5 V(Adapter Input AC 230 V/ 50 Hz), DC 5 V						
Test Result:	Pass	1	(3)		CA	

Frequency(MHz)	Polarity	Position	Field Strength(V/m)	Observation
80 ~ 1000	V&H	Front	3	Note ⊠1
80 ~ 1000	V&H	Rear	3	Note ⊠1
80 ~ 1000	V&H	Left	3	Note ⊠1
80 ~ 1000	V&H	Right	3	Note ⊠1

Note:

- There was no change compared with initial operation during and after the test. No unintentional response was found during the test.
- 2. The function stopped during the test, but can be recoverable by itself operation after the test.
- 3. The function stopped during the test, but can be recoverable manually after the test.

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8.4. Electrical Fast Transient (EFT)

8.4.1. Test Specification

EN 61000-4-4 signal ports and telecommunication ports: ±0.5 kV (peak)
signal ports and telecommunication ports: +0.5 kV (peak)
input d.c. power port: ±0.5 kV (peak) input a.c. power ports: ±1 kV (peak)
Positive & Negative
5 kHz
5/50 ns
15 ms
300 ms
2 minutes per level & polarity
: B

8.4.2. Test Instruments

Immunity Shield Room									
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due					
Fast Transient Burst Simulator	Prima	EFT61004BG	PR12074375	Aug. 11, 2017					
Capacitive coupling folder	Prima	EFT-CLAMP	N/A	Aug. 11, 2017					
Single-phase transformer	Prima	JMB-3KVA	L12121902-2	Aug. 11, 2017					

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

8.4.3. Test Method

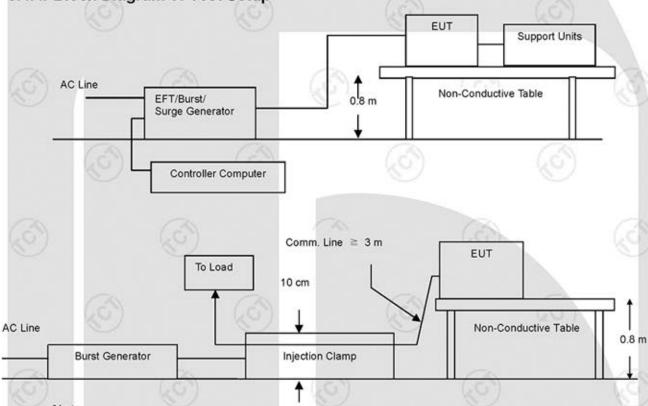
- The EUT and its simulators were placed on the ground reference plane and were insulated from it by a wood support 0.1 m + 0.01 m thick. The ground reference plane was 1 m*1 m metallic sheet with 0.65 mm minimum thickness.
- This reference ground plane was project beyond the EUT by at least 0.1 m on all sides and the minimum distance between EUT and all other conductive structure, except the ground plane was more than 0.5 m.
- All cables to the EUT was placed on the wood support, cables not subject to EFT/B
 was routed as far as possible from the cable under test to minimize the coupling
 between the cables.

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- 4. The length of the signal and power lines between the coupling device and the EUT is 0.5 m.
- The EUT is connected to the power mains through a coupling device that directly couples the EFT/B interference signal.
- 6. Each of the Line and Neutral conductors is impressed with burst noise for 2 minutes.

8.4.4. Block Diagram of Test Setup



Note:

1. Table-top Equipment

The configuration consisted of a wooden table (0.8 m high) standing on the Ground Reference Plane. The GRP consisted of a sheet of aluminum (at least 0.25 mm thick and 2.5 m square) connected to the protective grounding system. A minimum distance of 0.5 m was provided between the EUT and the walls of the laboratory or any other metallic structure.

2. Floor-standing Equipment

The EUT installed in a representative system as described in section 7 of IEC 61000-4-4 and its cables, were isolated from the Ground Reference Plane by an insulating support that is 0.1-meter thick. The GRP consisted of a sheet of aluminum (at least 0.25 mm thick and 2.5 m square) connected to the protective grounding system.



8.4.5. Test Results

Test Environment:	Temp.:	23 ℃	Humid.:	53 %	Press.:	96 kPa	
Test Mode:	Mode 1	(,0	9	(26)		(3	
Test Voltage:	DC 5 V(Adapter Input AC 230 V/ 50 Hz)						
Test Result:	Pass	0	(3)		GA.		

Test Point	Polarity	Test Level (kV)	Performance Criterion	Observation
L (6)	+/-	(G)1	В	Note
N	+/-	1	В	Note
C L-N	+/-	1 /	В	Note
PE	67	- 6	7 -	N/A
L-PE				N/A
N – PE		(C)_	-(0)	N/A
L-N-PE		-		N/A
DC Port	C67	- 6	J) -	N/A
telecommunication port	~-	"	-	N/A
Signal port		(A)-	(%)	N/A

Note:

- There was no change compared with initial operation during and after the test. No unintentional response was found during the test.
- 2. The function stopped during the test, but can be recoverable by itself operation after the test.
- 3. The function stopped during the test, but can be recoverable manually after the test.

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8.5. Surges

8.5.1. Test Specification

est Requirement:	EN 55024						
est Method:	EN 61000-4-5						
est Level:	signal ports and telecommunication ports: ±1/4 kV(peak) input d.c. power port: ±0.5 kV (peak) input a.c. power ports: Line to line: ±1 kV(peak) Line to ground: ±2 kV(peak)						
Polarity:	Positive & Negative						
Vave-Shape:	1.2/50 us; 8 /20 us; 10 /700 us						
Senerator Source mpedance:	2 ohm between networks 12 ohm between network and ground						
est Interval:	60 s between each surge						
lumber of Tests:	5 positive, 5 negative at 0°, 90°, 180°, 270°.						
Performance Criterion:	B&C						

8.5.2. Test Instruments

Immunity Shield Room						
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due		
Lightning Surge Generator	Prima	SUG61005BG	PR12125534	Aug. 11, 2017		
Single-phase transformer	Prima	JMB-3KVA	L12121902-2	Aug. 11, 2017		

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

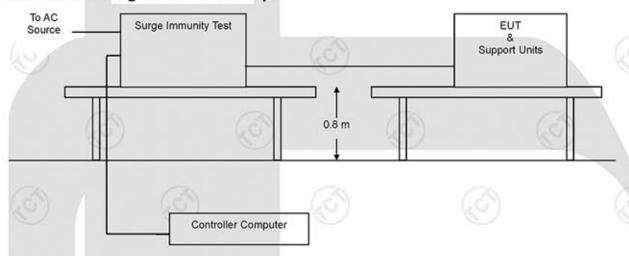
8.5.3. Test Method

- For line-to-line coupling mode, provide a 1 kV 1.2/50 us voltage surge (at open-circuit condition) and 8/20 us current surge to EUT selected points, and for active line / neutral lines to ground are same except test level is 2 kV.
- At least 5 positive and 5 negative (polarity) tests with a maximum 1/min repetition rate are applied during test.
- Different phase angles are done individually.
- Record the EUT operating situation during compliance test and decide the EUT immunity criterion for above each test.

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8.5.4. Block Diagram of Test Setup



8.5.5. Test Results

Test Environment:	Temp.:	22 °C	Humid.:	52 %	Press.:	96 kPa
Test Mode:	Mode 1	80)	(6)		(6)
Test Voltage:	DC 5 V(Adapter In	put AC 230 \	V/ 50 Hz)		
Test Result:	Pass	9	(E))	(co	

Test Point	Polarity	Test Level (kV)	Performance Criterion	Observation
L - N 🕙	+/-	(C)	В	Note ☐1 ☐2 ☐3
L - PE	-			N/A
N - PE	(4)		.c^ -	N/A
DC Port			-	N/A
telecommunication port	- \	/35	-0	N/A
Signal port	-	(C)	-(0)	N/A

Note

- There was no change compared with initial operation during and after the test. No unintentional response was found during the test.
- 2. The function stopped during the test, but can be recoverable by itself operation after the test.
- 3. The function stopped during the test, but can be recoverable manually after the test.



8.6. Radio-frequency Continuous Conducted (CS)

8.6.1. Test Specification

Test Requirement:	EN 55024	((4))		((0))
Test Method	EN 61000-4-6			
Frequency Range:	0.15 MHz - 80 MHz		CAS	
Test Level:	3 V r.m.s. (unmodulated)			
Modulation:	1 kHz, 80 % AM, sine wave			
Performance Criterion:	A	(20)		The same

8.6.2. Test Instrument

CS Test							
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due			
Conducted Disturbances Test System	Schloder	CDG 6000-75	126B1290	Aug. 12, 2017			
CDN	Schloder	CDN M2+M3-16	A2210281	Aug. 16, 2017			
Attenuator	Schloder	ATT-6DB-100	A100W225	Aug. 16, 2017			
EM-Clamp	Schloder	EMCL-20	132A1194	Aug. 16, 2017			

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

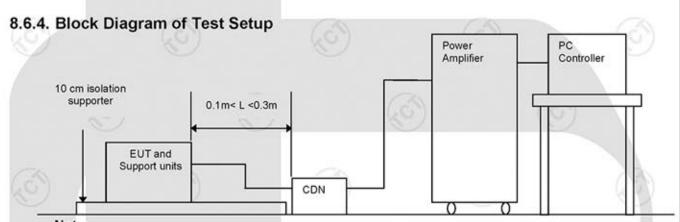
8.6.3. Test Method

- 1. The EUT are placed on an insulating support 0.1 m high above a ground reference plane. CDN (coupling and decoupling device) is placed on the ground plane about 0.3 m from EUT. Cables between CDN and EUT are as short as possible, and their height above the ground reference plane shall be between 30 and 50 mm (where possible).
- The disturbance signal described below is injected to EUT through CDN.
- The EUT operates within its operational mode(s) under intended climatic conditions after power on.
- 4. The frequency range is swept from 0.150 MHz to 80 MHz using 3 V signal level, and with the disturbance signal 80 % amplitude modulated with a 1 kHz sine wave.

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Recording the EUT operating situation during compliance testing and decide the EUT immunity criterion.



Note:

Table-Top and Floor-Standing Equipment

The equipment to be tested is placed on an insulating support of 0.1 meters height above a ground reference plane. All relevant cables shall be provided with the appropriate coupling and decoupling devices at a distance between 0.1 meters and 0.3 meters from the projected geometry of the EUT on the ground reference plane.

8.6.5. Test Results

Test Environment:	Temp.:	22 °C	Humid.:	52 %	Press.:	96 kPa
Test Mode:	Mode 1		E.)	6	
Test Voltage:	DC 5 V(A	Adapter Inp	out AC 230 V	/ 50 Hz)		
Test Result:	Pass	6	G))	8	5)	The state of

Frequency Band (MHz)	Field Strength (Vrms)	Injected Position	Injection Method	Performance Criterion	Observation
0.15 ~ 80	3	AC Mains	CDN-M2	Α	Note ⊠1
0.15 ~ 80	(- 5)	-\ (<u> </u>	/ - (3)	N/A

Note:

- There was no change compared with initial operation during and after the test. No unintentional response
 was found during the test.
- 2. The function stopped during the test, but can be recoverable by itself operation after the test.
- 3. The function stopped during the test, but can be recoverable manually after the test.

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8.7. Power-frequency Magnetic Field (PFMF)

8.7.1. Test Specification

Test Requirement:	EN 55024		
Test Method:	EN 61000-4-8		
Frequency:	50/60 Hz	6 /	20
Test level:	1 A/m	9	9
Observation Time:	5 minutes		
Performance criterion:	A CA	(29)	78

8.7.2. Test Instrument

Immunity Shield Room							
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due			
Continuous Wave Simulator	EM TEST	UCS 500 M4	0304-42	Aug. 16, 2017			
Power Source Network	EM TEST	MV 2616	0104-14	Aug. 16, 2017			
Magnetic Coil	EM TEST	MS100	0304-42	Aug. 16, 2017			

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

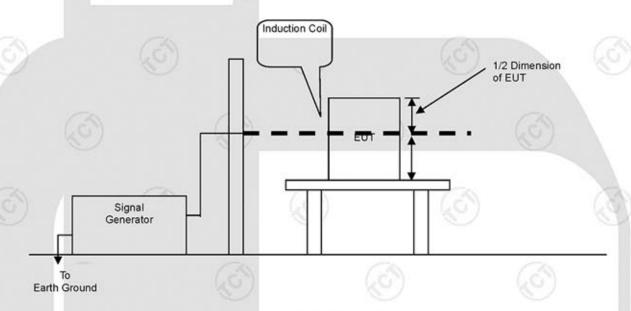
8.7.3. Test Method

- the equipment is configured and connected to satisfy its functional requirements.
 It shall be placed on the GRP with the interposition of a 0.1 m-thick insulating support.
- the equipment cabinets shall be connected to the safety earth directly on the GRP via the earth terminal of the EUT.
- the power supply, input and output circuits shall be connected to the sources of power supply, control and signal.
- the cables supplied or recommended by the equipment manufacturer shall be used.
 meter of all cables used shall be exposed to the magnetic field.

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8.7.4. Block Diagram of Test Setup



Note:

1. Table-top Equipment

The equipment shall be subjected to the test magnetic field by using the induction coil of standard dimension (1 m x 1 m). The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

2. Floor-standing Equipment

The equipment shall be subjected to the test magnetic field by using induction coils of suitable dimensions. The test shall be repeated by moving and shifting the induction coils, in order to test the whole volume of the EUT for each orthogonal direction. The test shall be repeated with the coil shifted to different positions along the side of the EUT, in steps corresponding to 50 % of the shortest side of the coil. The induction coil shall then be rotated by 90 degrees in order to expose the EUT to the test field with different orientations.

8.7.5. Test Results

Note: This test isn't applicable because the EUT doesn't have relative function.

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8.8. Voltage Dip & Voltage Interruptions

8.8.1. Test Specification

Test Requirement:	EN 55024
Test Level:	>95 % of U _T (Supply Voltage) for 0.5 periods 30% of U _T (Supply Voltage) for 25 periods >95 % of U _T (Supply Voltage) for 250 periods
Performance Criterion:	B&C

8.8.2. Test Instrument

	Immunity shielded room							
Name of Equipment	Manufacturer	Model	Serial Number	Calibration Due				
Cycle Sag Simulator	Prima	DRP61011AG	PR12106201	Aug. 11, 2017				
Single-phase transformer	Prima	JMB-3KVA	L12121902-2	Aug. 11, 2017				

Note: The calibration interval of the above test instruments is 12 months and the calibrations are traceable to international system unit (SI).

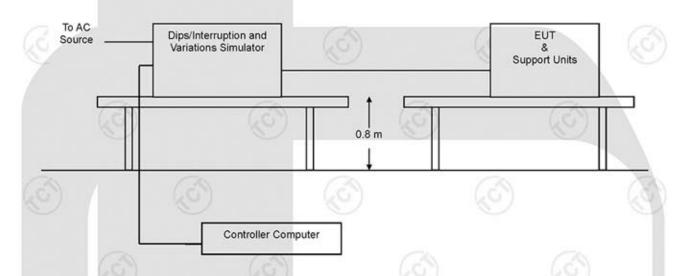
8.8.3. Test Method

- The EUT and support units were located on a wooden table, 0.8 m away from ground floor.
- 2. Setting the parameter of tests and then perform the test software of test simulator.
- 3. Conditions changes to occur at 0 degree crossover point of the voltage waveform.
- Recording the test result in test record form.

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8.8.4. Block Diagram of Test Setup



8.8.5. Test Results

Test Environment:	Temp.:	22 ℃	Humid.:	52 %	Press.:	96 kPa
Test Mode:	Mode 1					
Test Voltage:	DC 5 V(Adapter In	put AC 230 \	V/ 50 Hz)	(d)	
Test Result:	Pass					

Voltage (%Reduction)	Duration (cycle)	Performance Criterion	Observation
100	0.5	□A ⊠B □C	Note
30	25	□A □B ⊠C	Note
100	250	□A □B ⊠C	Note ☐1 ☐2 ☑3

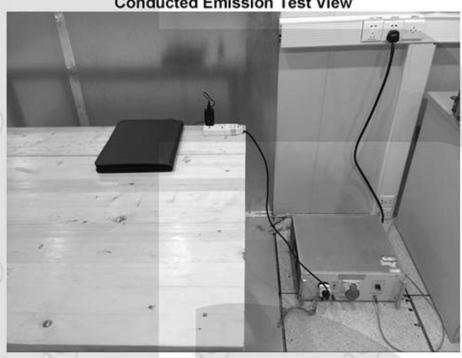
Note:

- There was no change compared with initial operation during and after the test. No unintentional response was found during the test.
- 2. The function stopped during the test, but can be recoverable by itself operation after the test.
- 3. The function stopped during the test, but can be recoverable manually after the test.

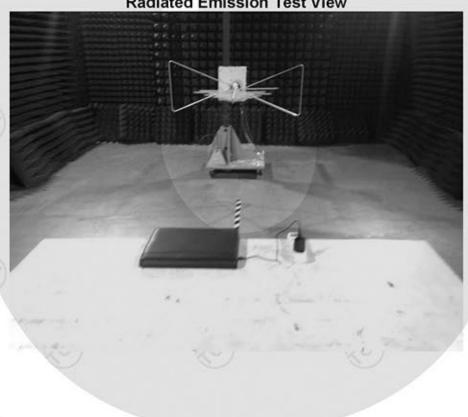


Photographs of Test Configuration 9.

Conducted Emission Test View



Radiated Emission Test View



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Flicker Test View



ESD Test View



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EFT Test View



Surges Test View



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Report No.: TCT170220E001

CS Test View



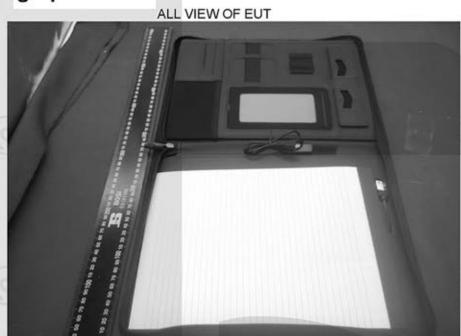
Voltage Dips/Interruptions Test View



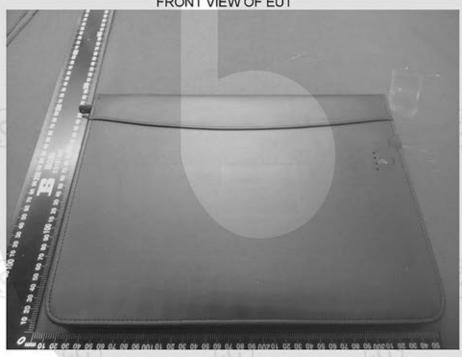
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10. Photographs of EUT



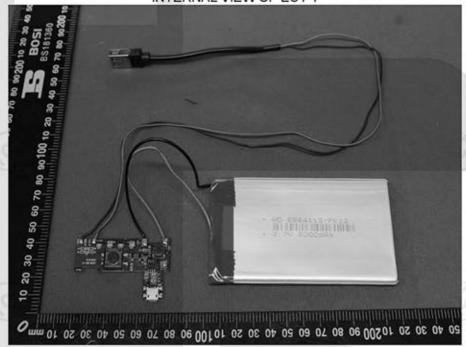


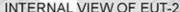


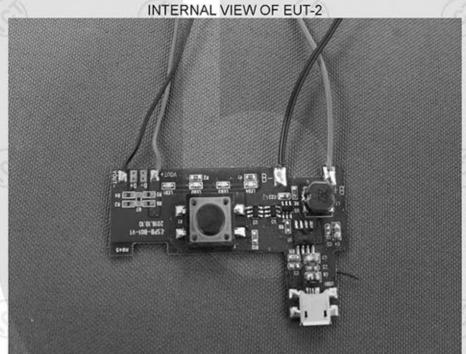
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INTERNAL VIEW OF EUT-1

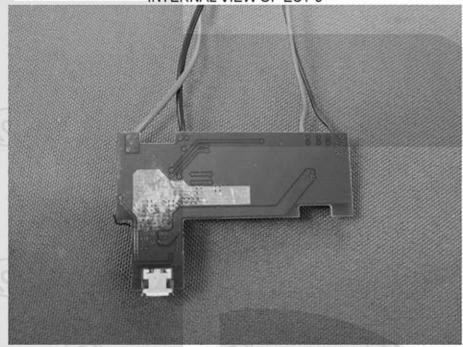












*****END OF REPORT****



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